TOSHIBA BIPOLAR LINEAR INTEGRATED CIRCUIT SILICON MONOLITHIC

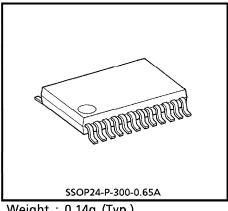
TA2056FNG

1.5V CORDLESS HEADPHONE RECEIVER

The TA2056FNG is an infrared ray linear audio signal receiver IC developed for IR cordless headphone systems. It is two built in FM receivers for stereo and muting function etc.

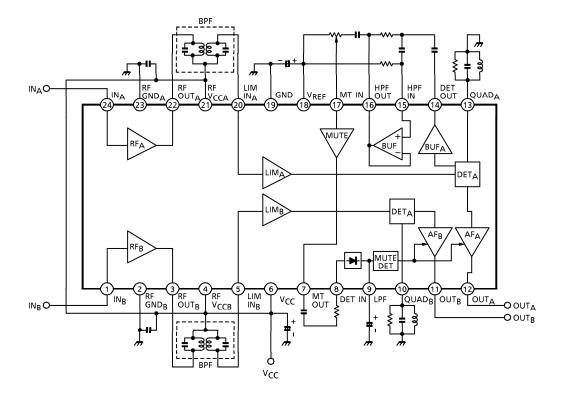
FEATURES

- Two built-in FM receivers for stereo (f = 2.3 / 2.8 MHz)
- Excellent spurious radiation by direct detection type
- Built-in muting function (retuned noise detection type)
 - Built-in buffer amplifier for muting signal detection
 - Built-in muting amplifier
 - Built-in detector circuit
 - Muting attenuation (V_{CC} = 1.2V, Ta = 25°C) ATT = 65 dB (Typ.)
- Two built-in RF amplifiers
- Low supply current (V_{CC} = 1.2V, Ta = 25°C) $I_{CC} = 4.0 \text{mA}$ (Typ.)
- Operating supply voltage range (Ta = 25°C) V_{CC (opr)} = 0.95~2.2V
- (*) Handle with care to prevent devices from deterioration by static electricity.



Weight : 0.14g (Typ.)

BLOCK DIAGRAM



BPF

We recommended

2.3MHz : TH354BAI-6727 (TOKO, INC.)

2.8MHz : TH354BAI-6728 (TOKO, INC.)

TERMINAL EXPLANATION

TERMINAL VOLTAGE : Typical voltage at no signal with test circuit ($V_{CC} = 1.2V$, Ta = 25°C)

TERMINAL No.	NAME	FUNCTION	INTERNAL CIRCUIT	TERMINAL VOLTAGE (V)
1	INB	Input of RF amplifier ● Input impedance : 3.3kΩ (Typ.)	3	0.7
24	INA	 A resistor (R≤330Ω) should be connected to GND through a capacitor 		0.7
2	$RF\ GND_B$	GND of RF amplifier		0
23	$RF\ GND_A$			U
3	$RF OUT_B$	Output of RF amplifier		
22	$RF OUT_{A}$			
4	RF V _{CCB}	V _{CC} , for RF amplifier and part		1.2
21	RF V _{CCA}	of limiter amplifier		1.2
5	lim in _b	Input of limiter amplifier Input impedance		1.2
20 LIM IN _A		: 1.8kΩ (Typ.)		
6	Vcc	V _{CC} , except RF V _{CC}		1.2
7	MT OUT	Output of muting amplifier		0.5
17	MT IN	Input of muting amplifier It is necessary to connect a resistor between V _{REF} terminal (pin [®]) and this terminal (pin [®]) for bias.	$\begin{array}{c} & & \\ & \\ & \\ & \\ & \\ & \\ & \\ & \\ & \\ $	0.7
8	DET IN	Input of muting detector circuit	- II w	0.7

TERMINAL No.	NAME	FUNCTION	INTERNAL CIRCUIT	TERMINAL VOLTAGE (V)
9	LPF	Smoothing circuit of muting signal	→ → → → → → → → → → → → → → → → → → →	_
10	QUAD _B	OUAD detector		0
13	QUAD _A	QUAD detector		0
11	out _b	Output of audio signal • Output impedance		0.6
12	ουτ _Α	: 1kΩ (Typ.)		
14	DET OUT	 Detector output for muting function This terminal is detector output of FM detector, it can be used for muting signal detection. Output impedance : 2kΩ (Typ.) 		0.5
15	HPF IN	Input of HPF for muting signal detection		0.7
16	HPF OUT	Output of HPF for muting signal detection		0.7
18	VREF	Reference circuit		0.7
19	GND		_	0

APPLICATION NOTE

1. Input of RF amplifier (PIN (1) / (2))

A resistor ($R \le 330\Omega$) should be connected to GND through a capacitor. Because input impedance of this terminal is designed for $3.3k\Omega$ (Typ.), internal circuit doesn't operate normally.

2. Muting function (Retuned noise detection type)

The muting function is operated by audio amplifier muting which is decided by noise level which is taken out by high-pass filter from recovered output voltage of channel A. Muting signal is detected only channel A, not from channel B.

The detected noise level peaks near the input limiting voltage. Bellow the input limiting voltage, the noise level decreases and there is a possibility that the muting function doesn't operate normally.

Thus in case that muting sensitivity is set near the input limiting voltage, it is necessary to caution that the muting function operate normally.

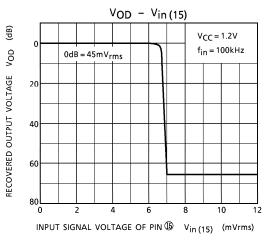


Fig. Muting sensitivity

3. Pattern layout

The TA2056FNG has three V_{CC} and GND terminals. External parts should be connected with each V_{CC} and GND shortly, these pattern layouts should be isolated.

/RF V _{CCA} (pin ⁽¹⁾)、RF GND _A (pin ⁽³⁾)	RF amp. (A-ch), part of LIM amp. (A-ch)
(RF V _{CCB} (pin \textcircled{A})、 RF GND _B (pin \textcircled{D})	RF amp. (B-ch), part of LIM amp. (B-ch)
└ V _{CC} (pin ⑥)、GND (pin ⑲)	Except RF V _{CC} and RF GND

ABSOLUTE MAXIMUM RATINGS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	RATING	UNIT
Supply Voltage	Vcc	3	V
Power Dissipation	P _D (Note)	500	mW
Operating Temperature	T _{opr}	- 25~75	°C
Storage Temperature	T _{stg}	- 55~150	°C

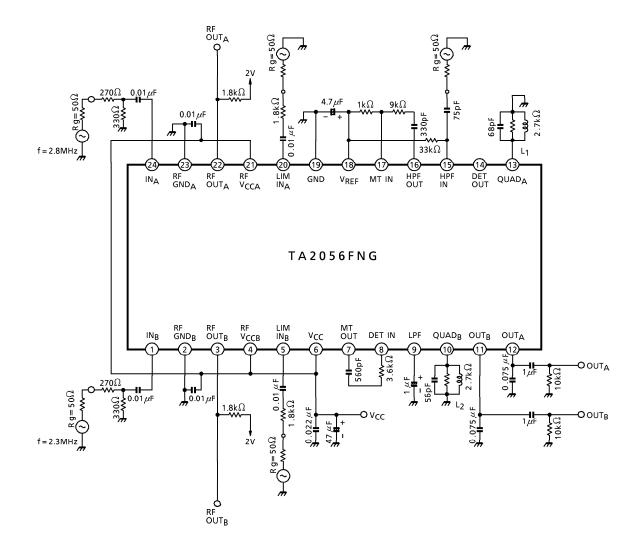
(Note) Derated above $Ta = 25^{\circ}C$ in the proportion of $4mW/^{\circ}C$.

ELECTRICAL CHARACTERISTICS

Unless otherwise specified : V_{CC} = 1.2V, Ta = 25°C f = 2.3 / 2.8MHz, f_m = 1kHz, Δ f = ± 22.5kHz, V_{in} = 80dB μ V EMF

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CHARACTERISTIC		SYMBOL	TEST CIR- CUIT	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Sup	ply Current	lcc	-	V _{in} =0	—	4.0	6.0	mA
Ref	erence Voltage	VREF	—		0.65	0.75	0.85	V
	RF Amp. Voltage Gain	GV	—	V _{in} = 10mVrms	—	8	—	dB
	Recovered Output Voltage 1	V _{OD1}	_	f = 2.8MHz	27	45	63	mVrms
Stage	Recovered Output Voltage 2	V _{OD2}		f = 2.3MHz	_	42	_	mVrms
Sta	V _{OD} Channel Balance	CB	—	V _{OD1} – V _{OD2}	- 1.4	+ 0.6	+ 2.6	dB
Receiver	Input Limiting Voltage	V _{in (lim)}	_	– 3dB limiting point	40	45	50	dBµV EMF
Rec	Total Harmonic Distortion	THD	_		_	0.2	_	%
	Signal to Noise Ratio	S/N	—	∆f = ±22.5kHz→0	_	56		dB
	AM Rejection Ratio	AMR	—	MOD = 30%	_	45		dB
	Cross Talk	СТ	—		—	55	—	dB
Stage	Muting Circuit Off Voltage	MT (OFF)	—	f = 100kHz, V _{OD} > – 3dB	-	_	2	mVrms
Muting 3	Muting Circuit On Voltage	MT (ON)	_	f = 100kHz, V _{OD} < - 40dB	12	_	_	mVrms
Σ	Muting Attenuation	ATT	_			65		dB

TEST CIRCUIT



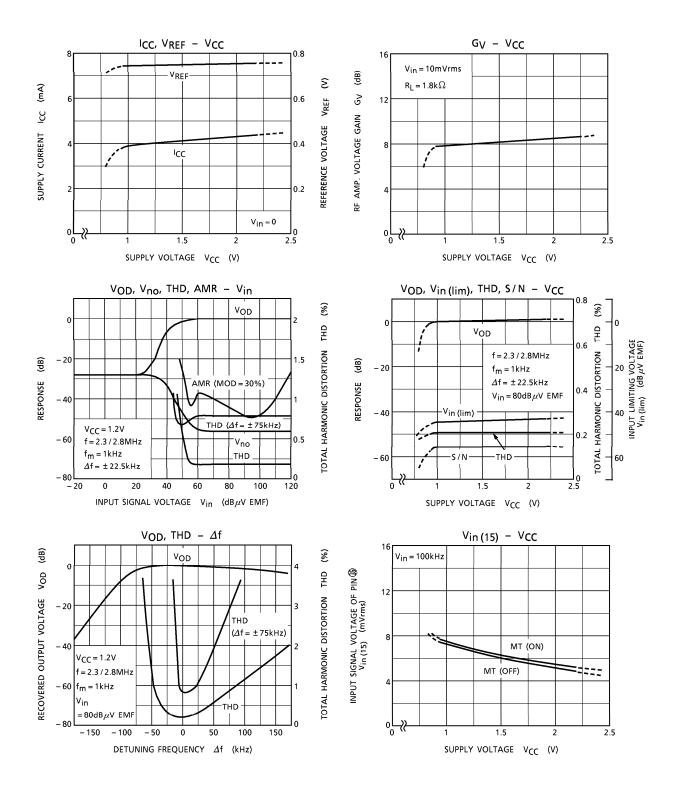
COIL DATA	(Test	circuit)	
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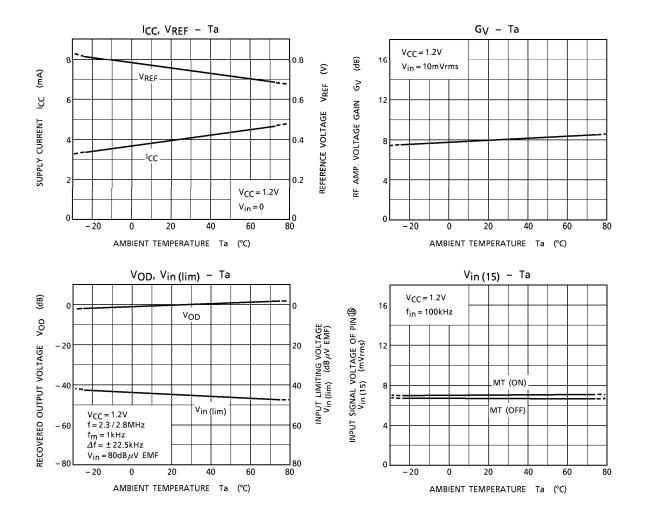
COIL	TEST FREQ.	L (μH)	L (µH) Q0	TURNS	WIRE	REFERENCE
NAME	NAME 1231 HEQ.		~0	1-3	(mm∮)	
L ₁ DET	2.52MHz	35	70	59	0.06UEW	©4165-JPS-047-6
L ₂ DET	2.52MHz	60	65	74	0.06UEW	\$4165-JPS-047-11

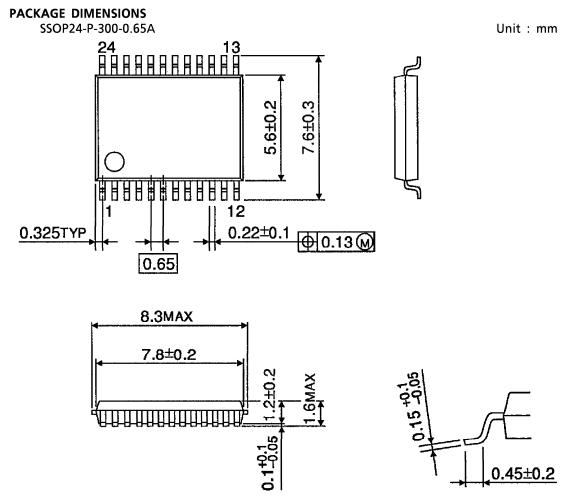


(BOTTOM VIEW)

 $\ensuremath{\mathbb{S}}$: sumida electric co., LTD.







Weight : 0.14g (Typ.)

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About solderability, following conditions were confirmed

- Solderability
 - (1) Use of Sn-37Pb solder Bath
 - solder bath temperature = 230°C
 - dipping time = 5 seconds
 - the number of times = once
 - · use of R-type flux
 - (2) Use of Sn-3.0Ag-0.5Cu solder Bath
 - solder bath temperature = 245°C
 - dipping time = 5 seconds
 - the number of times = once
 - use of R-type flux